Evaluated electron and positronmolecule scattering data for modelling particle transport in the energy range 0-10000 eV **Gustavo García** Instituto de Física Fundamental **Consejo Superior de Investigaciones Científicas** (IFF-CSIC) Madrid, Spain

Modelling tools for molecular data validation

- High energy (E>10 keV) primary radiation (photons, electrons and ions): GEometry ANd Tracking4 (GEANT4)
- Low energy (E<10 keV) seconday particles (electrons, positrons and radicals): Low Energy Particle Track Simulation (LEPTS)

Modelling procedure to validate interaction data in molecular media



Input data

- High energy photons and ions: (Literature: Evaluated Data Bases)
- High energy (>10keV) electrons/positrons : (First Born approximation- Bethe surfaces)
- Low energy electron, positrons and radicals : (Evaluated theoretical and experimental data-EPEDAT)

Electron and positron evaluated data EPEDAT

• Experimental sources:

- Electron and positron scattering with molecules: CSIC, Flinders University (FU), Universidade Nova de Lisboa (UNL), Sophia University (SU), Australian National University (ANU)
- Electron transfer to molecules: CSIC, New University of Lisbon (UNL)
- Thoretical methods:
 - Electron and positron scattering with molecules: CSIC (IAM-SCAR), Open University (R-matrix), University of Innsbruck (Single-Centre Expansion)

Beam-gas experiments-1



Beam-gas experiments-2 e/p magnetically confined beam



ANU-Canberra (p) CSIC-Madrid (e)

Crossed-beam experiments-1



Crossed-beam experiments-2 electron transfer induced dissociation



Calculations

Electron and positron scattering in molecular and condensed media

- Atoms: Model potential representation,
- Molecules:
 - Independent atom model (IAM), Aditivity rule (AR)
 with screening corrections (SCAR) and interference
 terms
 - Additional dipole rotational excitations (FBA)
- **Condensation effects:** Atomic and molecular clusters, liquids, solids (IAM-SCAR)
- Low energy (< 20 eV) extension : Single-Centre Expansion and R-Matrix procedures

Atoms

Electrons: $V(r) = V_{st}(r) + V_{ex}(r) + V_{pol}(r) + i[V_{abs}(r)]$

Positrons: $V(r) = V_{st}(r) + V_{pol}(r) + i[V_{abs}(r) + V_{ps}(r)]$

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Molecules

Differential cross sections

$$\frac{d\sigma_{molecule}^{elastic}}{d\Omega} = \sum_{i,j} f_i(\theta) f_j^*(\theta) \frac{\sin qr_{ij}}{qr_{ij}} = \sum_i |f_i(\theta)|^2 + \sum_{i\neq j} f_i(\theta) f_j^*(\theta) \frac{\sin qr_{ij}}{qr_{ij}}$$

Integral cross sections

$$\sigma_{molecule}^{total} = \sum_{atoms} \sigma_{atomi}^{total} + \sigma^{interference}$$

$$\sigma^{interference} \equiv \int d\Omega \sum_{i \neq j} f_i(\theta) f_j^*(\theta) \frac{\sin qr_{ij}}{qr_{ij}}$$

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Condensed matter

High \rightarrow Intermediate \rightarrow Low EnergyCorrective factor: $s = \sigma^{eff}/\sigma = [1 + (\sigma^c/\sigma)^p]^{1/p}$ P=-21 \rightarrow 0,5% convergence

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Some examples of calculations

Differential elastic scattering cross sections e-GeF₄

Experimental data from
 H. Tanaka (SU Tokyo)
 IAM-SCAR calculation

Some examples of calculations

Total electron scattering cross sections e-CH₄

Example of input data

Three main classes of input data are needed:

Uncertainties: 5-20%

10-20%

10-20%

Integral CS: 0.1 eV – 10 keV

1. Scattering CS

- Total scattering CS (5-7%)
- Integral CS for:
 - elastic scattering (10-15%)
 - Ionization (7-10%)
 - electronic excitation (20%)
 - vibrational excit. (20%)
 - rotational excit. (10-15%)
 - neutral dissociation (25%)
 - DEA (10-15%)
 - self-consistency: Σ int. CS = total CS
- CS table is compiled from typically ~ 15 different sources!

total cross section

Differential CS 0° -180°

3. Angular distrib. functions

Elastic DCS

- Tabulated values from 0° to 180° on a 1° grid from ~6 sources
- Data from experimental sources are extrapolated towards 0° and 180°

Inelastic DCS

- Aim: tabulated form, 0°-180°
- present source: approximation by empirical formula

$$\frac{\mathrm{d}^2\,\sigma(E)}{\mathrm{d}\,\Omega\mathrm{d}\,\Delta E} \propto \left(\frac{\mathrm{d}\,\sigma(E)}{\mathrm{d}\,\Omega}\right)_{el}^{1-\Delta E/E}$$

e-Furfural Energy loss distribution function

Current state of the Madrid data collection

Molecules currently included:

- Water (e, p)
- Argon (e,p)
- Nitrogen, Oxygen (e,p)
- Methane (e)
- Ethylene (e)
- Tetrahydrofuran (e)
- Sulphur hexafluoride (e)
- Pyrimidine (e, p)
- Furfural (e)

Processes currently included:

- elastic scattering
- ionization, Auger e- generation
- vibrational and rotational excitation (average of existing states)
- electronic excitation (all states according to EEL spectra)
- neutral dissociation
- dissociative electron attachment
- positronium formation
- annihilation

Example: 10keV electrons through furfural

Importance of energy loss uncertainties

Importance of elastic scattering

Particle transport data evaluation: 20 eV magnetically confined electrons transmitted through 140

mm length gas (3 mTorr furfural pressure) cell

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